

**Silicon Diffused Power Transistor****BU2525DW****GENERAL DESCRIPTION**

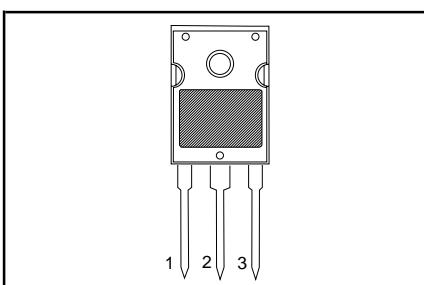
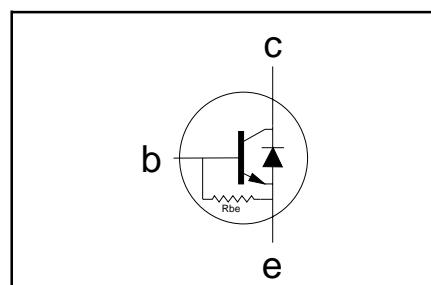
New generation, high-voltage, high-speed switching npn transistor with integrated damper diode in a plastic envelope intended for use in horizontal deflection circuits of large screen colour television receivers up to 32 kHz.

**QUICK REFERENCE DATA**

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$V_{CESM}$	Collector-emitter voltage peak value	$V_{BE} = 0$	-	1500	V
$V_{CEO}$	Collector-emitter voltage (open base)		-	800	V
$I_C$	Collector current (DC)		-	12	A
$I_{CM}$	Collector current peak value		-	30	A
$P_{tot}$	Total power dissipation		-	125	W
$V_{CEsat}$	Collector-emitter saturation voltage	$T_{mb} \leq 25^\circ\text{C}$	-	5.0	V
$I_{Csat}$	Collector saturation current	$I_C = 8.0 \text{ A}; I_B = 1.6 \text{ A}$	8	-	A
$t_s$	Storage time	$I_{Csat} = 8.0 \text{ A}; I_{B(end)} = 1.1 \text{ A}$	3.0	4.0	$\mu\text{s}$

**PINNING - SOT429**

PIN	DESCRIPTION
1	base
2	collector
3	emitter
tab	collector

**PIN CONFIGURATION****SYMBOL****LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum Rating System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CESM}$	Collector-emitter voltage peak value	$V_{BE} = 0 \text{ V}$	-	1500	V
$V_{CEO}$	Collector-emitter voltage (open base)		-	800	V
$I_C$	Collector current (DC)		-	12	A
$I_{CM}$	Collector current peak value		-	30	A
$I_B$	Base current (DC)		-	8	A
$I_{BM}$	Base current peak value		-	12	A
$-I_{B(AV)}$	Reverse base current	average over any 20 ms period	-	200	mA
$-I_{BM}$	Reverse base current peak value <sup>1</sup>		-	9	A
$P_{tot}$	Total power dissipation	$T_{mb} \leq 25^\circ\text{C}$	-	125	W
$T_{stg}$	Storage temperature		-65	150	$^\circ\text{C}$
$T_j$	Junction temperature		-	150	$^\circ\text{C}$

**THERMAL RESISTANCES**

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$R_{th j-mb}$	Junction to mounting base	-	-	1.0	K/W
$R_{th j-a}$	Junction to ambient	in free air	45	-	K/W

<sup>1</sup> Turn-off current.

## Silicon Diffused Power Transistor

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## STATIC CHARACTERISTICS

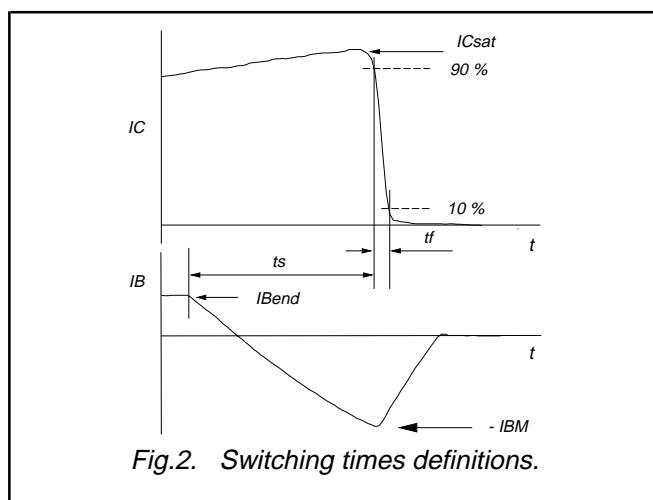
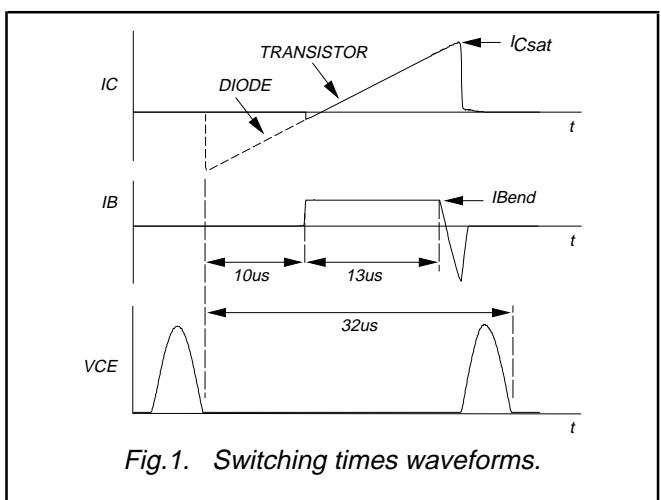
 $T_{mb} = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$I_{CES}$	Collector cut-off current <sup>2</sup>	$V_{BE} = 0 \text{ V}; V_{CE} = V_{CESMmax}$	-	-	1.0	mA
$I_{CES}$		$V_{BE} = 0 \text{ V}; V_{CE} = V_{CESMmax}$ ; $T_j = 125^\circ\text{C}$	-	-	2.0	mA
$I_{EBO}$	Emitter cut-off current	$V_{EB} = 6.0 \text{ V}; I_c = 0 \text{ A}$	72	110	218	mA
$R_{EB}$	Base-emitter resistance	$V_{EB} = 6.0 \text{ V}$	-	55	-	$\Omega$
$BV_{EBO}$	Emitter-base breakdown voltage	$I_B = 600 \text{ mA}$	7.5	13.5	-	V
$V_{CEOusust}$	Collector emitter-sustaining voltage	$I_B = 0 \text{ A}; I_c = 100 \text{ mA}; L = 25 \text{ mH}$	800	-	-	V
$V_{CEsat}$	Collector-emitter saturation voltage	$I_c = 8.0 \text{ A}; I_B = 1.6 \text{ A}$	-	-	5.0	V
$V_{BEsat}$	Base-emitter saturation voltage	$I_c = 8.0 \text{ A}; I_B = 1.6 \text{ A}$	-	-	1.1	V
$h_{FE}$	DC current gain	$I_c = 1 \text{ A}; V_{CE} = 5 \text{ V}$	-	11	-	
$h_{FE}$		$I_c = 8 \text{ A}; V_{CE} = 5 \text{ V}$	5	7	9.5	
$V_F$	Diode forward voltage	$I_F = 8 \text{ A}$	-	1.6	2.0	V

## DYNAMIC CHARACTERISTICS

 $T_{mb} = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$C_c$	Collector capacitance	$I_E = 0 \text{ A}; V_{CB} = 10 \text{ V}; f = 1 \text{ MHz}$	145	-	pF
$t_s$	Switching times (32 kHz line deflection circuit)	$I_{Csat} = 8.0 \text{ A}; L_C = 260 \mu\text{H}; C_{fb} = 13 \text{ nF}; I_{B(end)} = 1.1 \text{ A}; L_B = 2.5 \mu\text{H}; -V_{BB} = 4 \text{ V}; (-dI_B/dt) = 1.6 \text{ A}/\mu\text{s}$			
$t_f$	Turn-off storage time Turn-off fall time		3.0 0.2	4.0 0.35	$\mu\text{s}$ $\mu\text{s}$
$V_{fr}$	Anti-parallel diode forward recovery voltage	$I_F = 8 \text{ A}; dI_F/dt = 50 \text{ A}/\mu\text{s}$	16		V
$t_{fr}$	Anti-parallel diode forward recovery time	$V_F = 5 \text{ V}$	410		ns

<sup>2</sup> Measured with half sine-wave voltage (curve tracer).

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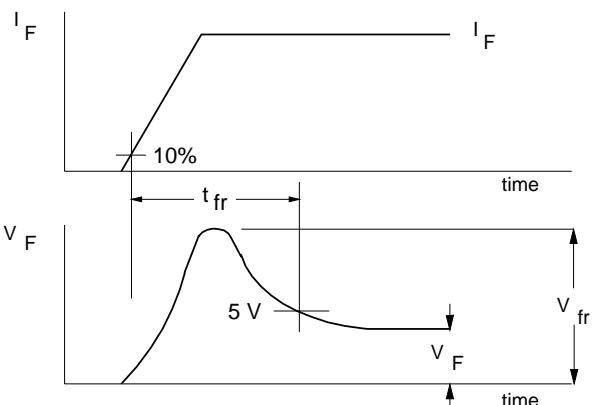
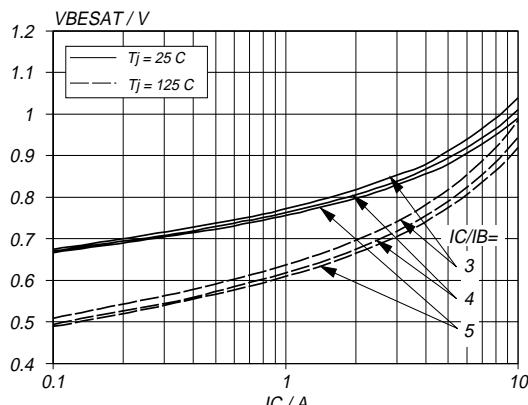
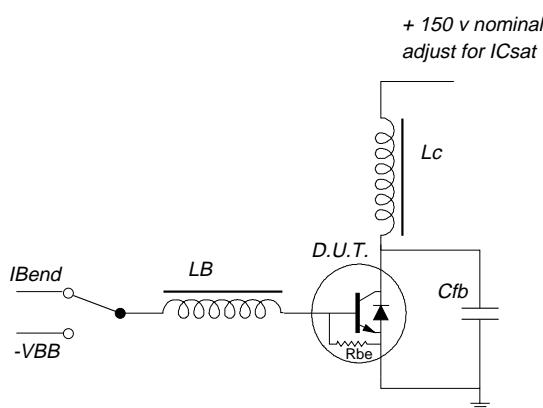
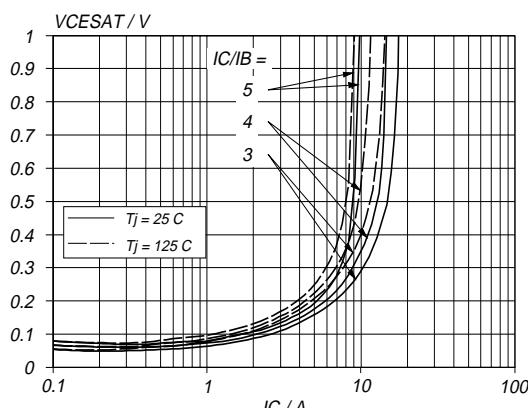
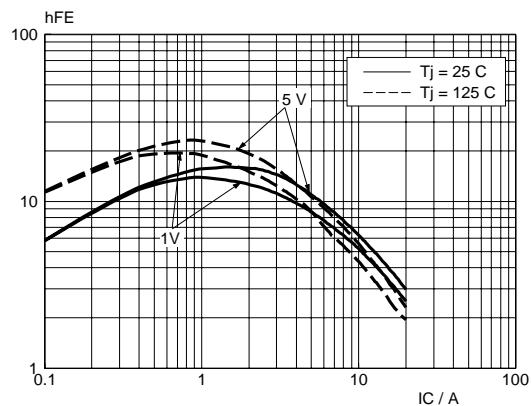
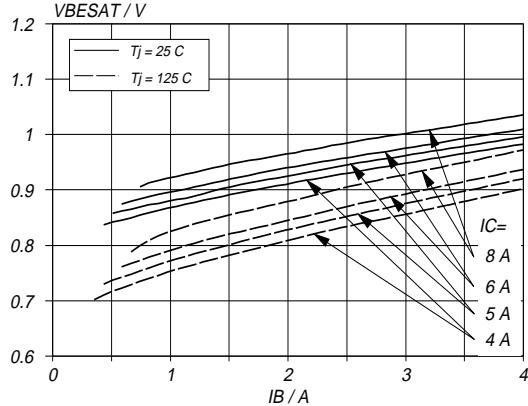
Fig.3. Definition of anti-parallel diode  $V_{fr}$  and  $t_{fr}$ Fig.6. Typical base-emitter saturation voltage.  
 $V_{BEsat} = f (I_C)$ ; parameter  $I_C/I_B$ 

Fig.4. Switching times test circuit

Fig.7. Typical collector-emitter saturation voltage.  
 $V_{CEsat} = f (I_C)$ ; parameter  $I_C/I_B$ Fig.5. Typical DC current gain.  $h_{FE} = f (I_C)$   
parameter  $V_{CE}$ Fig.8. Typical base-emitter saturation voltage.  
 $V_{BEsat} = f (I_B)$ ; parameter  $I_C$

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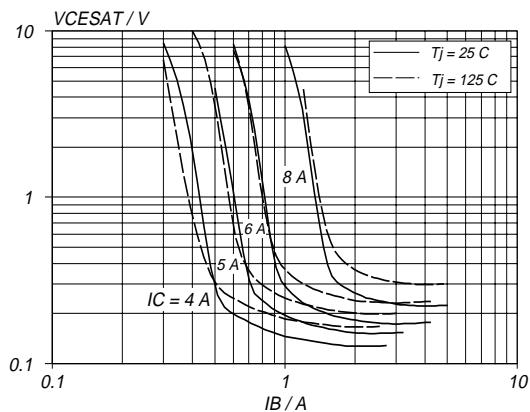


Fig.9. Typical collector-emitter saturation voltage.  
 $V_{CEsat} = f(I_B)$ ; parameter  $I_C$

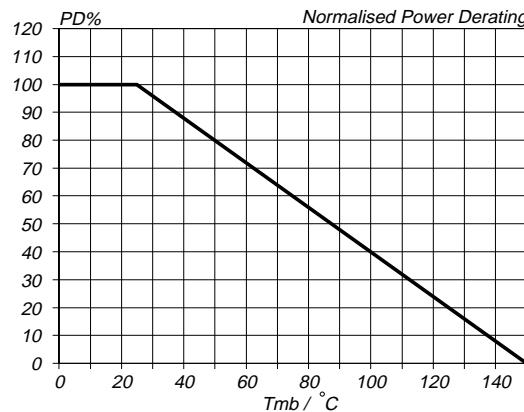


Fig.12. Normalised power dissipation.  
 $PD\% = 100 \cdot P_D / P_{D, 25^\circ C} = f(T_{mb})$

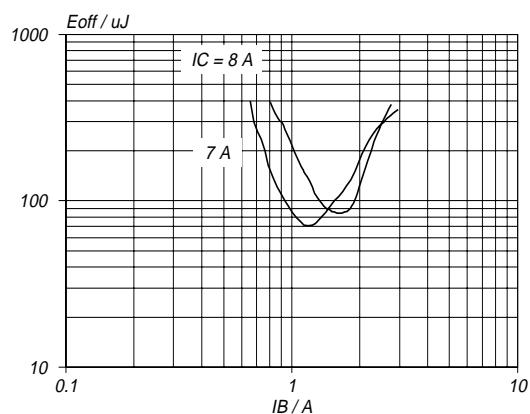


Fig.10. Typical turn-off losses.  $T_j = 85^\circ C$   
 $E_{off} = f(I_B)$ ; parameter  $I_C$ ;  $f = 32$  kHz

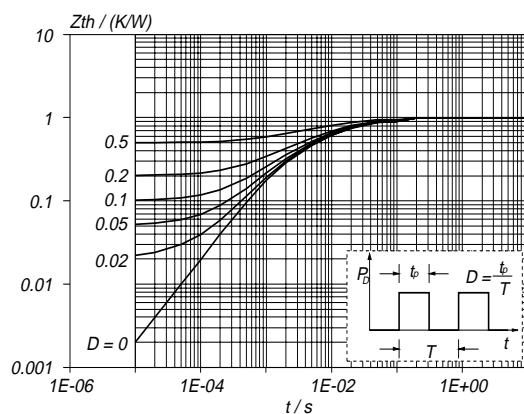


Fig.13. Transient thermal impedance.  
 $Z_{th,j-mb} = f(t)$ ; parameter  $D = t_p/T$

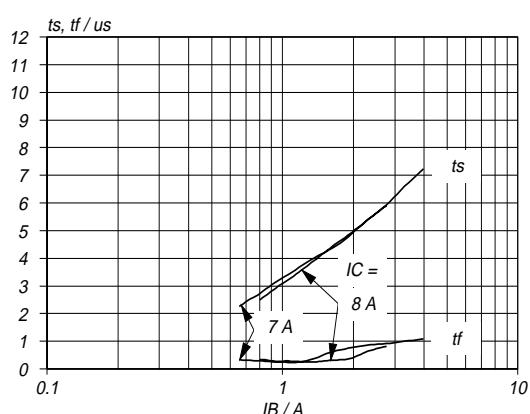
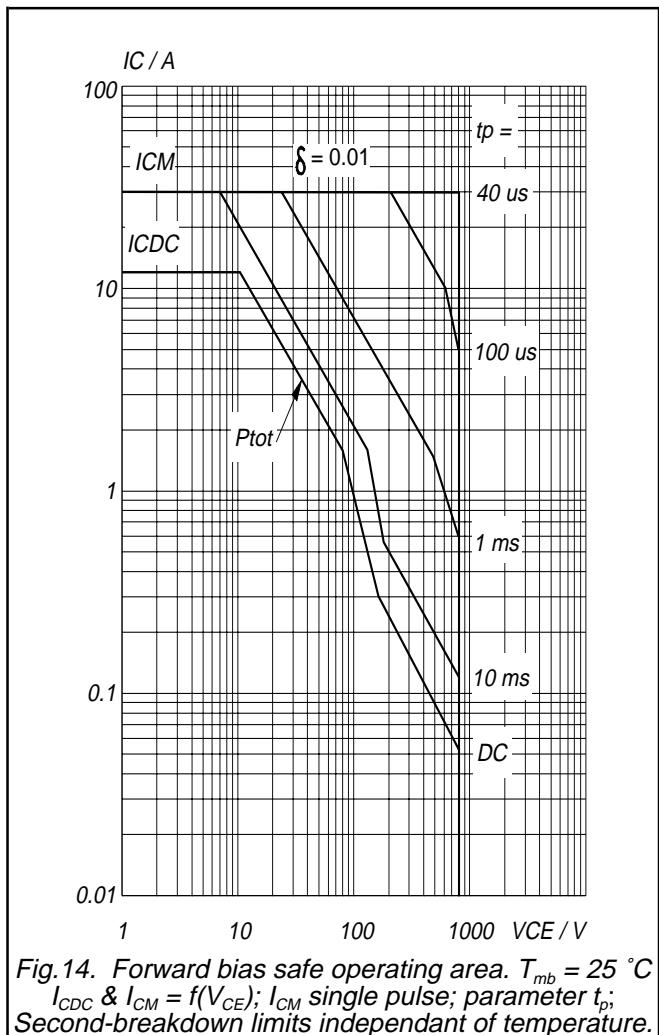


Fig.11. Typical collector storage and fall time.  
 $t_s = f(I_B)$ ;  $t_f = f(I_B)$ ; parameter  $I_C$ ;  $T_j = 85^\circ C$ ;  $f = 32$  kHz

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## MECHANICAL DATA

*Dimensions in mm*

Net Mass: 5 g

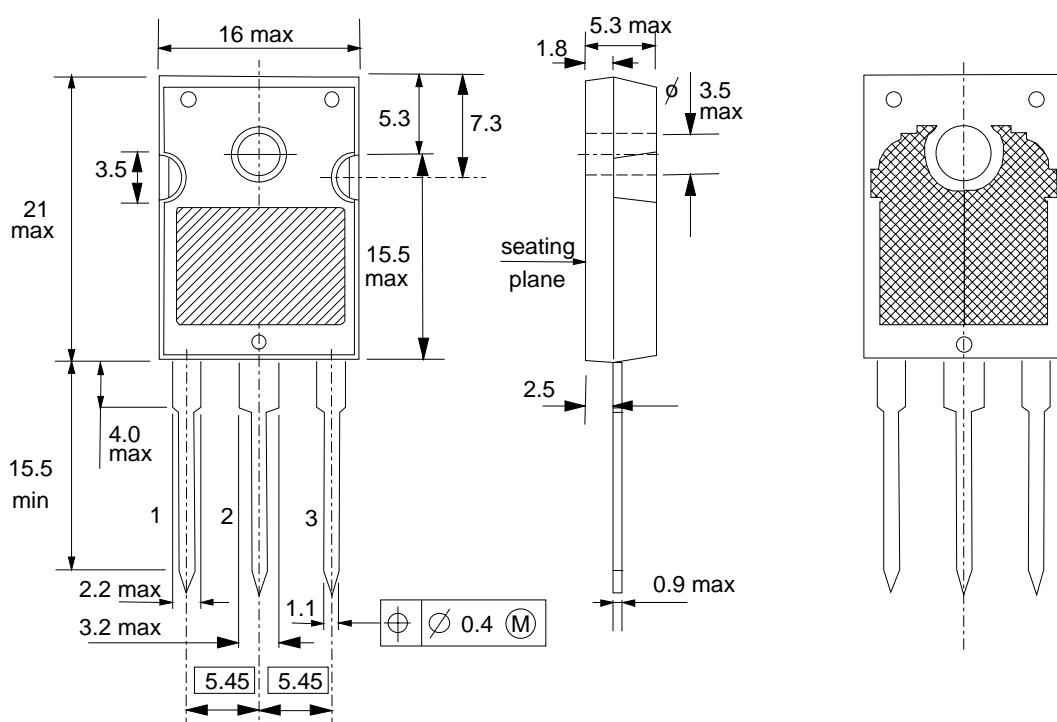


Fig.15. SOT429; pin 2 connected to mounting base.

## Notes

1. Refer to mounting instructions for SOT429 envelope.
2. Epoxy meets UL94 V0 at 1/8".

**Silicon Diffused Power Transistor****BU2525DW****DEFINITIONS**

<b>Data sheet status</b>	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
<b>Limiting values</b>	
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
<b>Application information</b>	
Where application information is given, it is advisory and does not form part of the specification.	
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